

**Notice of References Cited**

Application/Control No.

10/537,576

Applicant(s)/Patent Under  
Reexamination  
RUMPF ET AL.

Examiner

William J. Klimowicz

Art Unit

2627

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,633,554	05-1997	Kaji, Takatoshi	310/328
*	B	US-5,732,058	03-1998	Iwamura et al.	720/629
*	C	US-5,856,966	01-1999	Nakamichi, Niro	720/622
*	D	US-5,952,766	09-1999	Mukohjima et al.	310/323.04
*	E	US-6,068,256	05-2000	Slutskiy et al.	271/264
*	F	US-6,242,850	06-2001	Slutskiy et al.	310/328
*	G	US-6,337,532	01-2002	Johansson et al.	310/323.02
*	H	US-7,146,619	12-2006	Kikkoji, Hiroyuki	720/619
*	I	US-5,878,011	03-1999	Nakamichi, Niro	720/606
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 63316676 A	12-1988	Japan	ONISHI, YOSHITAKA	
	O	JP 2001211670 A	08-2001	Japan	NISHINO, SATOSHI	
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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